



<p align="center"><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10671777</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>PECK ET AL.</p>
	<p>Examiner</p> <p>Kaplan, Hal I</p>	<p>Art Unit</p> <p>2836</p>

Class	SubClass	Date	Examiner
219	485	09/13/2006	HK
361	65	09/13/2006	HK

U.S. Patent and Trademark Office	Part of Paper No.: 20060913
----------------------------------	-----------------------------

<b>Search Notes</b>  	Application/Control No.  10671777	Applicant(s)/Patent Under Reexamination  PECK ET AL.
	Examiner Kaplan, Hal I	Art Unit 2836

Notes	Date	Examiner
219/483,485,486,508 (consulted Mark Paschall)	02/16/2006	HK
361/62,63,65 (consulted Stephen W. Jackson)	02/16/2006	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TD B) - See Search History Printout	09/13/2006	HK
U.S. Patent and Trademark Office		Part of Paper No.: 20060913